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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/812,064	NAGAOKA ET AL.	
Examiner	Art Unit	
Jill L. Heitbrink	1732	

	SEAR	CHED	
Class	Subclass	Date	Examiner
264	40.1	3/29/2007	JLH
	40.7		
	219		
425	145		
	163		
700	200	<b>√</b>	1

INTERFERENCE SEARCHED			
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SEAR( INCLUDING SE)	CH NOTE	ES TRATEGY	
		DATE	EXMR
inventor search		3/29/2007	JLH
EAST search		3/29/2007	JLH
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